

# SN54ALS1003A, SN74ALS1003A QUADRUPLE 2-INPUT POSITIVE-NAND BUFFERS WITH OPEN-COLLECTOR OUTPUTS

SDAS239 – D2661, APRIL 1982 – REVISED MAY 1986

- Buffer Version of 'ALS03B
- Package Options include Plastic Small Outline Packages, Ceramic Chip Carriers, and Standard Plastic and Ceramic 300-mil DIPs
- Dependable Texas Instruments Quality and Reliability

## description

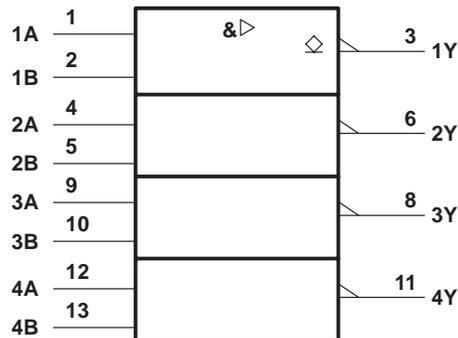
These devices contain four independent 2-input NAND buffers. They perform the Boolean functions  $Y = \overline{A \cdot B}$  or  $Y = \overline{A+B}$  in positive logic. The open-collector outputs require pullup resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher  $V_{OH}$  levels.

The SN54ALS1003A is characterized for operation over the full military temperature range of  $-55^{\circ}\text{C}$  to  $125^{\circ}\text{C}$ . The SN74ALS1003A is characterized for operation from  $0^{\circ}\text{C}$  to  $70^{\circ}\text{C}$ .

FUNCTION TABLE  
(each gate)

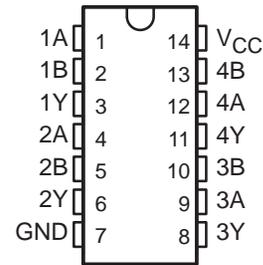
INPUTS		OUTPUT
A	B	Y
H	H	L
L	X	H
X	L	H

## logic symbol†

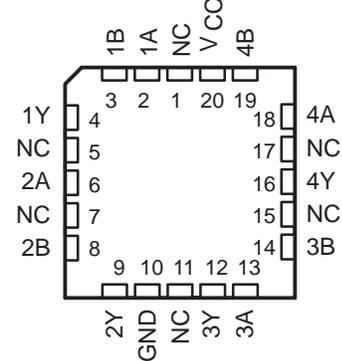


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.  
Pin numbers shown are for D, J, and N packages.

SN54ALS1003A ... J PACKAGE  
SN74ALS1003A ... D OR N PACKAGE  
(TOP VIEW)

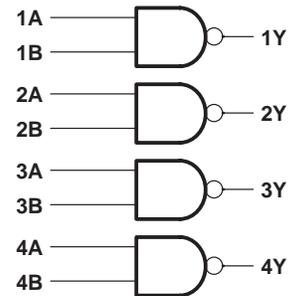


SN54ALS1003A ... FK PACKAGE  
(TOP VIEW)



NC – No internal connection

## logic diagram (positive logic)



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## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$	7 V
Input voltage	7 V
Off-state output voltage	7 V
Operating free-air temperature range: SN54ALS1003A	-55°C to 125°C
SN74ALS1003A	0°C to 70°C
Storage temperature range	-65°C to 150°C

## recommended operating conditions

		SN54ALS1003A			SN74ALS1003A			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
$V_{CC}$	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
$V_{IH}$	High-level input voltage	2			2			V
$V_{IL}$	Low-level input voltage			0.7			0.8	V
$V_{OH}$	High-level output voltage			5.5			5.5	V
$I_{OL}$	Low-level output current			12			24	mA
$T_A$	Operating free-air temperature	-55		125	0		70	°C

## electrical characteristics over recommended operating-free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	SN54ALS1003A			SN74ALS1003A			UNIT
		MIN	TYP†	MAX	MIN	TYP†	MAX	
$V_{IK}$	$V_{CC} = 4.5 V$ , $I_I = -18 mA$			-1.5			-1.5	V
$V_{OL}$	$V_{CC} = 4.5 V$ , $I_{OL} = 12 mA$		0.25	0.4		0.25	0.4	V
	$V_{CC} = 4.5 V$ , $I_{OL} = 24 mA$					0.35	0.5	
$I_{OH}$	$V_{CC} = 4.5 V$ , $V_{OH} = 5.5 V$			0.1			0.1	mA
$I_I$	$V_{CC} = 5.5 V$ , $V_I = 7 V$			0.1			0.1	mA
$I_{IH}$	$V_{CC} = 5.5 V$ , $V_I = 2.7 V$			20			20	μA
$I_{IL}$	$V_{CC} = 5.5 V$ , $V_I = 0.4 V$			-0.1			-0.1	mA
$I_{CCH}$	$V_{CC} = 5.5 V$ , $V_I = 0$		0.86	1.6		0.86	1.6	mA
$I_{CCL}$	$V_{CC} = 5.5 V$ , $V_I = 4.5 V$		4.8	7.8		4.8	7.8	mA

† All typical values are at  $V_{CC} = 5 V$ ,  $T_A = 25^\circ C$ .

## switching characteristics (see Note 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	$V_{CC} = 5 V$ , $C_L = 50 pF$ , $R_L = 680 \Omega$ , $T_A = 25^\circ C$	$V_{CC} = 4.5 V$ to $5.5 V$ , $C_L = 50 pF$ , $R_L = 680 \Omega$ , $T_A = MIN$ to $MAX$				UNIT
				'ALS1003A		SN74ALS1003A		
				TYP	MIN	MAX	MIN	
$t_{PLH}$	A or B	Y	18	10	40	10	33	ns
$t_{PHL}$	A or B	Y	7	2	18	2	12	ns

NOTE 1: Load circuit and voltage waveforms are shown in Section 1.



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